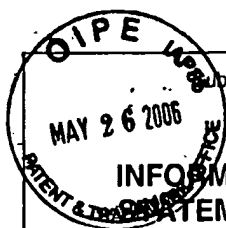


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# INFORMATION DISCLOSURE STATEMENT BY APPLICANT

## Complete if Known

Application Number	10/757,250
Filing Date	01-14-2004
First Named Inventor	Levine et al.
Examiner Name	Kendall, Chuck O.
Art Unit	2192
Attorney Docket No.	AUS920030488US1

Examiner Initials	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
/C.K./	AA 5051944	09-24-1991	Fetterolf et al.	
/C.K./	AB 5142634	08-25-1992	Fite et al.	
/C.K./	AC 5394529	02-28-1995	Brown, III et al.	
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/C.K./	AK 5537572	07-16-1996	Michelsen et al.	

## FOREIGN PATENT DOCUMENTS

Examiner Initial	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear

## NON PATENT LITERATURE

Examiner Initial	Include name of author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.
/C.K./	AL JEONG et al., "Cost Sensitive Cache Replacement Algorithms", June 2002, Second Workshop on Caching, Coherence and Consistency, NY, pp. 1-14.

Examiner: /Chuck Kendall/

Date Considered:

05/21/2008

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.